Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/662,728	GARG ET AL.		
Examiner	Art Unit		
Mark D. Fearer	2109		

	SEARCHED		
Class	Subclass	Date	Examiner
709	232	4/17/2007	MDF

TMI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
			_		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST Image and keyword search in USPAT, US-PGPUB, DERWENT, EPO, JPO, and IBM_TDB (see attached search strategy)	4/17/2007	MDF
consulted with Rafael Perez-Gutierrez	4/17/2007	MDF
garg.in. or kappes.in.	4/17/2007	MDF
AVAYA.as.	4/17/2007	MDF
@ad<"20030915" and ((random near3 early near3 (detect\$3 or discard\$3)) or ((back-pressure or (back near3 pressure))	4/17/2007	MDF
@ad<"20030915" and (Pause near3 frame)	4/17/2007	MDF
@ad<"20030915" and (Pause near3 frame near3 procedure near3 IEEE near3 "802.3") or (back-pressure or (back near3 pressure))	4/17/2007	MDF
"6650640" and (second)	4/17/2007	MDF